

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/718,064	FERRI ET AL.	
	Examiner	Art Unit	
	Ellen C. Tran	2134	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	5/23/2007	ECT
NPL - IEEE XPLORER	5/23/2007	ECT
INVENTOR - PALM/dDAN	5/23/2007	ECT
All claims were reviewed for possible 101 rejections	5/23/2007	ECT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner